Floating Electrode Design (FE-CAP), X7R Dielectric, 6.3 – 250 VDC (Commercial & Automotive Grade)



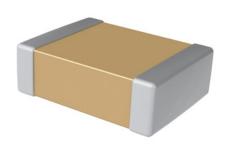
Overview

KEMET's Floating Electrode (FE-CAP) multilayer ceramic capacitor in X7R dielectric utilizes a cascading internal electrode design configured to form multiple capacitors in series within a single monolithic structure. This unique configuration results in enhanced voltage and ESD performance over standard capacitor designs while allowing for a fail-open condition if mechanically damaged (cracked). If damaged, the device may experience a drop in capacitance but a short is unlikely. The FE-CAP is designed to reduce the likelihood of a low IR or short circuit condition and the chance for a catastrophic and potentially costly failure event.

Driven by the demand for a more robust and reliable component, the FE-CAP was designed for critical applications where higher operating temperatures and mechanical stress are a concern. These capacitors are manufactured in state of the art ISO/TS 16949:2009 certified facilities and are widely used in power supplies (input and output filters) and general electronic applications.

Combined with the stability of an X7R dielectric, the FE-CAP complements KEMET's "Open Mode" devices by providing a fail-safe design optimized for low to mid range capacitance values. These devices exhibit a predictable change in capacitance with respect to time and voltage and boast a minimal change in capacitance with reference to ambient temperature. Capacitance change is limited to ±15% from -55°C to +125°C.

In addition to Commercial Grade, Automotive Grade devices are available which meet the demanding Automotive Electronics Council's AEC-Q200 qualification requirements.



Ordering Information

С	0805	S	104	K	5	R	A	С	TU
Ceramic	Case Size (L" x W")	Specification/ Series	Capacitance Code (pF)	Capacitance Tolerance	Rated Voltage (VDC)	Dielectric	Failure Rate/ Design	Termination Finish ¹	Packaging/ Grade (C-Spec)
	0402 0603 0805 1206 1210 1812	S = Floating Electrode	Two significant digits and number of zeros	J = ±5% K = ±10% M = ±20%	9 = 6.3 8 = 10 4 = 16 3 = 25 5 = 50 1 = 100 2 = 200 A = 250	R = X7R	A = N/A	C = 100% Matte Sn L = SnPb (5% Pb minimum)	See "Packaging C-Spec Ordering Options Table"

¹ Additional termination finish options may be available. Contact KEMET for details.

Built Into Tomorrow

¹ SnPb termination finish option is not available on automotive grade product.



Packaging C-Spec Ordering Options Table

Packaging Type	Packaging/Grade Ordering Code (C-Spec)
Commerc	ial Grade ¹
Bulk Bag	Not Required (Blank)
7" Reel/Unmarked	TU
13" Reel/Unmarked	7411 (EIA 0603 and smaller case sizes) 7210 (EIA 0805 and larger case sizes)
7" Reel/Marked	TM
13" Reel/Marked	7040 (EIA 0603) 7215 (EIA 0805 and larger case sizes)
Automoti	ve Grade ²
7" Reel	AUTO
13" Reel/Unmarked	AUTO7411 (EIA 0603 and smaller case sizes) AUTO7210 (EIA 0805 and larger case sizes)

¹ Default packaging is "Bulk Bag". An ordering code C-Spec is not required for "Bulk Bag" packaging.

Benefits

- -55°C to +125°C operating temperature range
- Floating Electrode/fail open design
- · Low to mid capacitance flex mitigation
- Lead (Pb)-free, RoHS and REACH compliant
- EIA 0402, 0603, 0805, 1206, 1210, and 1812 case sizes
- DC voltage ratings of 6.3 V, 10 V, 16 V, 25 V, 50 V, 100 V, 200 V, and 250 V
- Capacitance offerings ranging from 150 pF to 0.22 μF

- Available capacitance tolerances of ±5%, ±10%, and ±20%
- Commercial and Automotive (AEC-Q200) grades available
- Non-polar device, minimizing installation concerns
- 100% pure matte tin-plated termination finish allowing for excellent solderability
- SnPb termination finish option available upon request (5% Pb minimum)

Applications

Typical applications include circuits with a direct battery or power source connection, critical and safety relevant circuits without (integrated) current limitation and any application that is subject to high levels of board flexure or temperature cycling. Examples include raw power input side filtering (power plane/bus), high current applications (automobile battery line) and circuits that cannot be fused to open. Markets include consumer, medical, industrial (power supply), automotive, aerospace and telecom.

¹ The terms "Marked" and "Unmarked" pertain to laser marking option of capacitors. All packaging options labeled as "Unmarked" will contain capacitors that have not been laser marked.

² Reeling tape options (Paper or Plastic) are dependent on capacitor case size (L" x W") and thickness dimension. See "Chip Thickness/Tape & Reel Packaging Quantities" and "Tape & Reel Packaging Information".

² For additional Information regarding "AUTO" C-Spec options, see "Automotive C-Spec Information".

² All Automotive packaging C-Specs listed exclude the option to laser mark components. Please contact KEMET if you require a laser marked option. For more information see "Capacitor Marking".



Automotive C-Spec Information

KEMET automotive grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC-Q200, Stress Test Qualification for Passive Components. These products are supported by a Product Change Notification (PCN) and Production Part Approval Process warrant (PPAP).

Automotive products offered through our distribution channel have been assigned an inclusive ordering code C-Spec, "AUTO." This C-Spec was developed in order to better serve small and medium-sized companies that prefer an automotive grade component without the requirement to submit a customer Source Controlled Drawing (SCD) or specification for review by a KEMET engineering specialist. This C-Spec is therefore not intended for use by KEMET OEM automotive customers and are not granted the same "privileges" as other automotive C-Specs. Customer PCN approval and PPAP request levels are limited (see details below.)

Product Change Notification (PCN)

The KEMET product change notification system is used to communicate primarily the following types of changes:

- Product/process changes that affect product form, fit, function, and/or reliability
- · Changes in manufacturing site
- Product obsolescence

KEMET Automotive	Customer Notifica	tion Due To:	Days Prior To			
C-Spec	Process/Product change	Obsolescence*	Implementation			
KEMET assigned ¹	Yes (with approval and sign off)	Yes	180 days minimum			
AUT0	Yes (without approval)	Yes	90 days minimum			

¹ KEMET assigned C-Specs require the submittal of a customer SCD or customer specification for review. For additional information contact KEMET.

Production Part Approval Process (PPAP)

The purpose of the Production Part Approval Process is:

- To ensure that supplier can meet the manufacturability and quality requirements for the purchased parts.
- To provide the evidence that all customer engineering design records and specification requirements are properly understood and fulfilled by the manufacturing organization.
- To demonstrate that the established manufacturing process has the potential to produce the part.

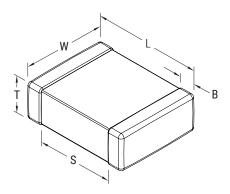
KEMET Automotive			PPAP Level		
C-Spec	1	2	3	4	5
KEMET assigned ¹	•	•	•	•	•
AUTO			0		

¹ KEMET assigned C-Specs require the submittal of a customer SCD or customer specification for review. For additional information contact KEMET.

- Part number specific PPAP available with customer information included.
- Product family PPAP only



Dimensions - Millimeters (Inches)



EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0402	1005	1.00 (0.040) ±0.05 (0.002)	0.50 (0.020) ±0.05 (0.002)		0.30 (0.012) ±0.10 (0.004)	0.30 (0.012)	Solder Reflow Only
0603	1608	1.60 (0.063) ±0.15 (0.006)	0.80 (0.032) ±0.15 (0.006)		0.35 (0.014) ±0.15 (0.006)	0.50 (0.020)	
0805	2012	2.00 (0.079) ±0.20 (0.008)	1.25 (0.049) ±0.20 (0.008)	See Table 2 for	0.50 (0.02) ±0.25 (0.010)	0.70 (0.028)	Solder Wave or Solder Reflow
1206	3216	3.20 (0.126) ±0.20 (0.008)	1.60 (0.063) ±0.20 (0.008)	Thickness	0.50 (0.02) ±0.25 (0.010)	1.50 (0.060)	
1210	3225	3.20 (0.126) ±0.20 (0.008)	2.50 (0.098) ±0.20 (0.008)		0.50 (0.02) ±0.25 (0.010)	1.50 (0.060)	Solder Reflow
1812	4532	4.50 (0.177) ±0.30 (0.012)	3.20 (0.126) ±0.30 (0.012)		0.60 (0.024) ±0.35 (0.014)	2.30 (0.091)	Only

Qualification/Certification

Commercial Grade products are subject to internal qualification. Details regarding test methods and conditions are referenced in Table 4, Performance and Reliability.

Automotive Grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC-Q200, Stress Test Qualification for Passive Components. For additional information regarding the Automotive Electronics Council and AEC-Q200, please visit their website at www.aecouncil.com.

Environmental Compliance

Lead (Pb)-free, RoHS, and REACH compliant without exemptions (excluding SnPb termination finish option).



Electrical Parameters/Characteristics

Item	Parameters/Characteristics
Operating Temperature Range	-55°C to +125°C
Capacitance Change with Reference to +25°C and 0 Vdc Applied (TCC)	±15%
¹ Aging Rate (Maximum % Capacitance Loss/Decade Hour)	3.0%
² Dielectric Withstanding Voltage (DWV)	250% of rated voltage (5±1 seconds and charge/discharge not exceeding 50mA)
³ Dissipation Factor (DF) Maximum Limit at 25°C	5%(6.3V & 10V), 3.5%(16V & 25V) and 2.5%(50V to 250V)
⁴ Insulation Resistance (IR) Minimum Limit at 25°C	See Insulation Resistance Limit Table (Rated voltage applied for 120±5 seconds at 25°C)

¹ Regarding Aging Rate: Capacitance measurements (including tolerance) are indexed to a referee time of 1,000 hours.

Note: When measuring capacitance it is important to ensure the set voltage level is held constant. The HP4284 & Agilent E4980 have a feature known as Automatic Level Control (ALC). The ALC feature should be switched to "ON".

Post Environmental Limits

1	High Temperature Life, Biased Humidity, Moisture Resistance												
Dielectric	Rated DC Voltage	Capacitance Value	Dissipation Factor (Maximum %)	Capacitance Shift	Insulation Resistance								
	> 25		3.0										
X7R	16/25	All	5.0	±20%	10% of Initial Limit								
	< 16		7.5										

² DWV is the voltage a capacitor can withstand (survive) for a short period of time. It exceeds the nominal and continuous working voltage of the capacitor.

 $^{^3}$ Capacitance and dissipation factor (DF) measured under the following conditions: 1kHz ± 50Hz and 1.0 ± 0.2 Vrms if capacitance ≤10 μ F 120Hz ± 10Hz and 0.5 ± 0.1 Vrms if capacitance >10 μ F

⁴ To obtain IR limit, divide M Ω -μF value by the capacitance and compare to G Ω limit. Select the lower of the two limits.



Insulation Resistance Limit Table (X7R Dielectric)

EIA Case Size	1,000 Megohm Microfarads or 100 GΩ	500 Megohm Microfarads or 10 GΩ
0201	N/A	ALL
0402	< 0.012 μF	≥ 0.012 µF
0603	< 0.047 μF	≥ 0.047 µF
0805	< 0.15 μF	≥ 0.15 µF
1206	< 0.47 μF	≥ 0.47 µF
1210	< 0.39 μF	≥ 0.39 µF
1808	ALL	N/A
1812	< 2.2 μF	≥ 2.2 µF
1825	ALL	N/A
2220	< 10 μF	≥ 10 µF
2225	ALL	N/A



Table 1A - Capacitance Range/Selection Waterfall (0402 - 0805 Case Sizes)

			se Si Serie			C	0402	2S				C	0603	BS						C08	058			
Capacitance	Cap	Vol	tage C	ode	9	8	4	3	5	9	8	4	3	5	1	2	9	8	4	3	5	1	2	Α
Capacitance	Code	Rate	ed Vol		6.3	1	16	25	50	6.3	1	92	25	20	100	200	6.3	10	91	25	20	100	200	250
		Ca	(VDC) pacita									ict Ava												
			oleran	ce								Table												
150 pF	151	J	K	M	BB	BB	BB	BB	BB	05		0.5	0.5	0.5									5.1	
180 pF	181	J	K	M	BB	BB	BB	BB	BB	CF	DN													
220 pF	221	J	K	M	BB BB	BB BB	BB BB	BB BB	BB BB	CF CF	DN DN	DN	DN DN	DN	DN	DN DN	DN DN	DN DN						
270 pF 330 pF	271 331	J	K	M	BB RR	BB BB	BB BB	BB RR	BB	CF	DN	DN DN	DN DN	DN DN	DN DN	DN	DN	DN						
390 pF	391	J	K	M	BB	BB	BB	BB	BB	CF	DN													
470 pF	471	J	K	M	BB	BB	BB	BB	BB	CF	DN													
560 pF	561	J	K	M	BB	BB	BB	BB	BB	CF	DN													
680 pF	681	J	K	M	BB	BB	BB	BB	BB	CF	DN													
820 pF	821	J	K	M	BB	BB	BB	BB	BB	CF	DN													
1,000 pF	102	J	K	M	BB	BB	BB	BB	BB	CF	DN													
1,200 pF	122	J	K	М						CF	DN													
1,500 pF	152	J	K	М						CF	DN													
1,800 pF	182	J	K	М						CF	DN													
2,200 pF	222	J	K	М						CF	DN													
2,700 pF	272	J	K	М						CF	DN													
3,300 pF	332	J	K	М						CF	DN													
3,900 pF	392	J	K	M						CF	DN													
4,700 pF	472	J	K	M						CF	DN													
5,600 pF	562	J	K	M						CF	CF	CF	CF	CF	CF		DN							
6,800 pF	682	J	K	M						CF	CF	CF	CF	CF	CF		DN							
8,200 pF	822	J	K	M						CF	CF	CF	CF	CF	CF		DN							
10,000 pF	103	J	K	M						CF	CF	CF	CF	CF			DN							
12,000 pF	123	J	K	M						CF	CF	CF	CF	CF			DN							
15,000 pF	153	J	K	M						CF	CF	CF	CF CF	CF			DN	DN	DN	DN	DN	DP		
18,000 pF	183 223	J	K	M M						CF CF	CF CF	CF CF	CF	CF CF			DN DN	DN DN	DN DN	DN DN	DN DN	DP DP		
22,000 pF 27,000 pF	273	J	K	M						UF.	CF	UF	UF	UF.			DN	DN	DN	DN	DN	DN		
33,000 pF	333	J	K	M													DN	DN	DN	DN	DN	DN		
39,000 pF	393	J	K	M													DN	DN	DN	DN	DN	DN		
47,000 pF	473	J	K	M													DN	DN	DN	DN	DN	DN		
56,000 pF	563	J	K	M													DP	DP	DP	DP	DP	DG		
68,000 pF	683	Ĵ	K	M													DP	DP	DP	DP	DP	DG		
82,000 pF	823	J	K	M													DG	DG	DG	DG	DG	DG		
0.10 μF	104	J	K	М													DG	DG	DG	DG	DG	DG		
0.12 μF	124	J	K	М													DG	DG	DG	DG	DG			
0.15 μF	154	J	K	М													DG	DG	DG	DG	DG			
0.18 μF	184	J	K	M						1							DG	DG	DG	DG	DG			
0.22 μF	224	J	K	M													DG	DG	DG	DG	DG			
0.27 μF	274	J	K	М													DG	DG	DG	DG				
0.33 μF	334	J	K	M													DG	DG	DG	DG			_	
	0	Rated Voltage (VDC)		6.3	2	16	25	20	6.3	1	16	25	20	100	200	6.3	2	16	25	20	100	200	250	
Capacitance	Cap Code Voltage Code Case Size/			9	8	4	3	5	9	8	4	3	5	1	2	9	8	4	3	5	1	2	A	
			se Si: Serie:				0402	s			C0603S						C0805S							



Table 1B - Capacitance Range/Selection Waterfall (1206 - 1812 Case Sizes)

			se Si erie					C12	06S							C12	108					С	1812	2S	
	Cap		tage C		9	8	4	3	5	1	2	Α	9	8	4	3	5	1	2	A	3	5	1	2	Α
Capacitance	Code		ed Volt		e e	2	16	52	20	100	200	250	6.3	2	9	52	20	9	200	250	52	20	100	200	250
			(VDC)		9	_	_	7	2	7								<u> </u>		7	7	2	=	7	5
			pacitar olerano											•		hip Tl cknes									
1,000 pF	102	J	K	М	EB					<u> </u>															
1,200 pF	122	J	K	М	EB																				
1,500 pF	152	J	K	М	EB																				
1,800 pF	182	J	K	М	EB																				
2,200 pF	222	J	K	М	EB	FB	FB	FB	FB	FB	FB	FB	FB												
2,700 pF	272	J	K	М	EB	FB	FB	FB	FB	FB	FB	FB	FB												
3,300 pF	332	J	K	М	EB	FB	FB	FB	FB	FB	FB	FB	FB												
3,900 pF	392	J	K	М	EB	FB	FB	FB	FB	FB	FB	FB	FB												
4,700 pF	472	J	K	М	EB	FB	FB	FB	FB	FB	FB	FB	FB												
5,600 pF	562	J	K	M	EB	FB	FB	FB	FB	FB	FB	FB	FB	0.0		0.0	0.0	0.0							
6,800 pF	682	J	K	M	EB	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB							
8,200 pF	822	J	K	M	EB	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB							
10,000 pF	103	J	K	M	EB	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB							
12,000 pF	123	J	K	M	EB	EB	EB	EB	EB	EB	EB EB	EB	FB FB	FB	FB FB	FB	FB FB	FB	FB	FB	GB	GB	GB	GB	GB
15,000 pF	153	J	K	M	EB EB	EB EB	EB EB	EB EB	EB EB	EB EB	EB	EB EB	FB	FB FB	FB	FB FB	FB	FB FB	FB FB	FB FB	GB GB	GB GB	GB GB	GB GB	GB GB
18,000 pF	183 223	J J	K K	M M	EB	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB							
22,000 pF 27,000 pF	273	J	K	M	EB	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB							
33,000 pF	333	J	K	M	EB	EB	EB	EB	EB	EB	ED	ED	FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB
39,000 pF	393	J	K	M	EB	EB	EB	EB	EB	EC			FB	FB	FB	FB	FB	FB	FB	FB	GB	GB	GB	GB	GB
47,000 pF	473	J	K	M	EB	EB	EB	EB	EB	EC			FB	FB	FB	FB	FB	FB	FC	FC	GB	GB	GB	GB	GB
56,000 pF	563	J	K	M	EB	EB	EB	EB	EB	EB			FB	FB	FB	FB	FB	FB	FC	FC	GB	GB	GB	GB	GB
68,000 pF	683	J	K	M	EB	EB	EB	EB	EB	EH			FB	FB	FB	FB	FB	FB		'	GB	GB	GB	GB	GB
82,000 pF	823	Ĵ	K	М	EB	EB	EB	EB	EB	EH			FB	FB	FB	FB	FB	FC			GB	GB	GB	GB	GB
0.10 μF	104	J	K	М	EB	EB	EB	EB	EB	EH			FB	FB	FB	FB	FB	FC			GB	GB	GB		
0.12 μF	124	J	K	М	EC	EC	EC	EC	EC	EH			FB	FB	FB	FB	FB				GB	GB	GB		
0.15 μF	154	J	K	М	EH	EH	EH	EH	EH	EH			FC	FC	FC	FC	FC				GB	GB	GB		
0.18 μF	184	J	K	М	EH	EH	EH	EH	EH	EH			FC	FC	FC	FC	FC				GB	GB	GK		
0.22 μF	224	J	K	М	EH	EH	EH	EH	EH	EH			FC	FC	FC	FC	FC				GB	GB	GK		
0.27 μF	274	J	K	М	EH	EH	EH	EH	EH	EH			FM	FM	FM	FM					GK	GK	GK		
0.33 μF	334	J	K	М	EH	EH	EH	EH	EH	EH			FM	FM	FM	FM					GK	GK	GK		
0.39 μF	394	J	K	М	EH	EH	EH	EH	EH	EH			FM	FM	FM	FM					GK	GK	GK		
0.47 μF	474	J	K	М	EH	EH	EH	EH	EH				FM	FM	FM	FM					GK	GK	GK		
0.56 μF	564	J	K	М	EH	EH	EH	EH	EH				FM	FM	FM	FM					GK	GK	GK		
0.68 μF	684	J	K	М	EH	EH	EH	EH	EH				FM	FM	FM	FM					GK	GK	GK		
0.82 μF	824	J	K	M	EH	EH	EH	EH					FM	FM	FM	FM					GK	GK	GK		
1.00 μF	105	J	K	M	EH	EH	EH	EH					FM	FM	FM	FM					GK	GK	GK		
1.20 µF	125	J	K	M									FM	FM	FM	FM					GK	GK			
1.50 µF	155	J	K K	M M									FM	FM	FM	FM FM					GK	GK			
1.80 µF	185 225	-		M									FM FM	FM FM	FM FM	FM					GK GK	GK GK			
2.20 μF 2.70 μF	275	J J	K K	M									I IVI	I IVI	I IVI	I IVI					GK	GK			
2.70 μF 2.30 μF	335	J	K	M																	GK				
Σ.ου μ.		Rated Voltage (VDC)		6.3	2	16	25	20	100	200	250	6.3	10	16	25	20	100	200	250	55	20	100	200	250	
Capacitance	Cap Code		tage C		9	8	4	3	5	1	2	Α	9	8	4	3	5	1	2	Α	3	5	1	2	Α
			se Siz Series					C12	06S				C1210S					(1812	s					



Table 2A - Chip Thickness/Tape & Reel Packaging Quantities

Thickness	Case	Thickness ±	Paper C	Quantity	Plastic (Quantity		
Code	Size	Range (mm)	7" Reel	13" Reel	7" Reel	13" Reel		
CJ	0603	0.80 ± 0.15	4,000	15,000	0	0		
DR	0805	0.78 ± 0.20	0	0	4,000	10,000		
DD	0805	0.90 ± 0.10	0	0	4,000	10,000		
DG	0805	1.25 ± 0.15	0	0	2,500	10,000		
EQ	1206	0.78 ± 0.20	0	0	4,000	10,000		
ER	1206	0.90 ± 0.20	0	0	4,000	10,000		
EH	1206	1.60 ± 0.20	0	0	2,000	8,000		
FN	1210	0.78 ± 0.20	0	0	4,000	10,000		
FQ	1210	0.90 ± 0.20	0	0	4,000	10,000		
FX	1210	0.95 ± 0.20	0	0	4,000	10,000		
FM	1210	1.70 ± 0.20	0	0	2,000	8,000		
GB	1812	1.00 ± 0.10	0	0	1,000	4,000		
GK	1812	1.60 ± 0.20	0	0	1,000	4,000		
Thickness	Case	Thickness ±	7" Reel	13" Reel	7" Reel	13" Reel		
Code	Size	Range (mm)	Paper C)uantity	Plastic Quantity			

Package quantity based on finished chip thickness specifications.

Table 2B - Bulk Packaging Quantities

Dookoa	ing Type	Loose Pa	ackaging						
Packay	ing Type	Bulk Bag	Bulk Bag (default)						
Packagir	ng C-Spec ¹	N,	'A²						
Case	e Size	Packaging Quantities (pieces/unit packaging)						
EIA (in)	Metric (mm)	Minimum	Maximum						
0402	1005								
0603	1608								
0805	2012		50,000						
1206	3216								
1210	3225	1							
1808	4520	'							
1812	4532								
1825	4564		20,000						
2220	5650								
2225	5664								

¹ The "Packaging C-Spec" is a 4 to 8 digit code which identifies the packaging type and/or product grade. When ordering, the proper code must be included in the 15th through 22nd character positions of the ordering code. See "Ordering Information" section of this document for further details. Commercial Grade product ordered without a packaging C-Spec will default to our standard "Bulk Bag" packaging. Contact KEMET if you require a bulk bag packaging option for Automotive Grade products.

² A packaging C-Spec (see note 1 above) is not required for "Bulk Bag" packaging (excluding Anti-Static Bulk Bag and Automotive Grade products). The 15th through 22nd character positions of the ordering code should be left blank. All product ordered without a packaging C-Spec will default to our standard "Bulk Bag" packaging.



Table 3 - Chip Capacitor Land Pattern Design Recommendations per IPC-7351

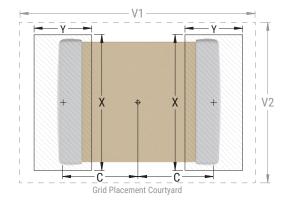
EIA Size Code	Metric Size Code	Density Level A: Maximum (Most) Land Protrusion (mm)				Density Level B: Median (Nominal) Land Protrusion (mm)				Density Level C: Minimum (Least) Land Protrusion (mm)						
Code	Odde	С	Y	X	V1	V2	С	Y	X	V1	V2	С	Υ	X	V1	V2
0402	1005	0.50	0.72	0.72	2.20	1.20	0.45	0.62	0.62	1.90	1.00	0.40	0.52	0.52	1.60	0.80
0603	1608	0.90	1.15	1.10	4.00	2.10	0.80	0.95	1.00	3.10	1.50	0.60	0.75	0.90	2.40	1.20
0805	2012	1.00	1.35	1.55	4.40	2.60	0.90	1.15	1.45	3.50	2.00	0.75	0.95	1.35	2.80	1.70
1206	3216	1.60	1.35	1.90	5.60	2.90	1.50	1.15	1.80	4.70	2.30	1.40	0.95	1.70	4.00	2.00
1210	3225	1.60	1.35	2.80	5.65	3.80	1.50	1.15	2.70	4.70	3.20	1.40	0.95	2.60	4.00	2.90
1210¹	3225	1.50	1.60	2.90	5.60	3.90	1.40	1.40	2.80	4.70	3.30	1.30	1.20	2.70	4.00	3.00
1812	4532	2.15	1.60	3.60	6.90	4.60	2.05	1.40	3.50	6.00	4.00	1.95	1.20	3.40	5.30	3.70

¹ Only for capacitance values ≥ 22 μF

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805 and 1206 case sizes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes. **Density Level C:** For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC-7351).

Image below based on Density Level B for an EIA 1210 case size.





Soldering Process

Recommended Soldering Technique:

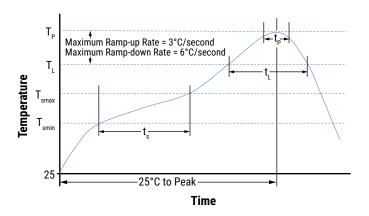
- Solder wave or solder reflow for EIA case sizes 0603, 0805 and 1206
- · All other EIA case sizes are limited to solder reflow only

Recommended Reflow Soldering Profile:

KEMET's families of surface mount multilayer ceramic capacitors (SMD MLCCs) are compatible with wave (single or dual), convection, IR or vapor phase reflow techniques. Preheating of these components is recommended to avoid extreme thermal stress. KEMET's recommended profile conditions for convection and IR reflow reflect the profile conditions of the IPC/ J-STD-020 standard for moisture sensitivity testing. These devices can safely withstand a maximum of three reflow passes at these conditions.

Profile Feature	Terminati	ion Finish
r tome i catale	SnPb	100% Matte Sn
Preheat/Soak		
Temperature Minimum (T _{Smin})	100°C	150°C
Temperature Maximum (T _{Smax})	150°C	200°C
Time (t_s) from T_{smin} to T_{smax}	60 - 120 seconds	60 - 120 seconds
Ramp-Up Rate (T _L to T _P)	3°C/second maximum	3°C/second maximum
Liquidous Temperature (T_L)	183°C	217°C
Time Above Liquidous (t _L)	60 - 150 seconds	60 - 150 seconds
Peak Temperature (T _P)	235°C	260°C
Time Within 5°C of Maximum Peak Temperature (t _p)	20 seconds maximum	30 seconds maximum
Ramp-Down Rate $(T_P \text{ to } T_L)$	6°C/second maximum	6°C/second maximum
Time 25°C to Peak Temperature	6 minutes maximum	8 minutes maximum

Note 1: All temperatures refer to the center of the package, measured on the capacitor body surface that is facing up during assembly reflow.





X7R Performance and Reliability: SMD Test Methods and Conditions

Test	Reference	Test Condition		Limits			
Visual and Mechanical	KEMET Internal	No defects that may affect performance (10X)	Di	mensions according KEME	T Spec Sheet		
Capacitance (Cap)	KEMET Internal	C ≤ 10 µF 1 kHz ±50 Hz and 1.0 ±0.2 V _{rms} or 0.5 ±0.2 V _{rms} * C > 10 µF 120 Hz ±10 Hz and 0.5 ±0.1 V _{rms} * See part number specification sheet for voltage Capacitance measurements (including tolerance) are indexed to a referee time of 1,000 hours. Please refer to a part number specification sheet for details	Within Tolerance				
Dissipation Factor (DF)	KEMET Internal	C ≤ 10 μF Frequency: 1 kHz ±50 Hz Voltage*: 1.0 ±0.2 V _{rms} C > 10 μF Frequency: 120 Hz ±10 Hz Voltage: 0.5 ±0.1 V _{rms} * See part number specification sheet for voltage		Within Specificati Maximum Limit at 2 5% (6.3V & 10V) 3.5% (16V & 25V) 2.5% (50V to 250	25°C) ') V)		
			insu EIA	Within Specificati Minimum Limit at 2 R limit, divide MΩ-μF value to GΩ limit. Select the low Llation Resistance (IR) 1,000 megohm	by the capacitance and yer of the two limits. Limits Table 500 megohm		
			Case Size	microfarads or 100 GΩ	microfarads or 10 GΩ		
			0201	N/A	ALL		
lm a l - 4t			0402	< .012 µF	≥ .012 µF		
Insulation Resistance	KEMET	Apply rated voltage for 120 seconds at 25°C	0805	< .047 μF < 0.15 μF	≥ .047 µF ≥ 0.15 µF		
(IR)	Internal		1206	< 0.47 μF	≥ 0.47 µF		
			1210	< 0.39 μF	≥ 0.39 µF		
			1805	ALL	N/A		
			1808	ALL	N/A		
			1812	< 2.2 μF	≥ 2.2 µF		
			1825	ALL	N/A		
			2220	< 10 μF	≥ 10 µF		
			2225	ALL	N/A		
			2220	, ALL	N/A		



X7R Performance and Reliability: SMD Test Methods and Conditions cont.

Test	Reference	Test Condition	Limits
Temperature Coefficient of Capacitance (TCC)	KEMET Internal	C ≤ 10µF Frequency: 1 kHz ±50 Hz Voltage*: 1.0 ±0.2 V _{rms} , C > 10µF Frequency: 120 Hz ±10 Hz Voltage: 0.5 ±0.1 V _{rms} * See part number specification sheet for voltage Step Temperature (°C) 1 +25°C	Capacitance ±15% over −55°C to +125°C
		2 -55°C 3 +25°C (Reference Temperature) 4 +125°C	
Dielectric Withstanding Voltage (DWV)	KEMET Internal	250% of rated voltage (5 ±1 seconds and charge/discharge not exceeding 50 mA)	Withstand test voltage without insulation breakdown or damage.
Aging Rate (Maximum % Capacitance Loss/Decade Hour)	KEMET Internal	Capacitance measurements (including tolerance) are indexed to a referee time of 1,000 hours. Please refer to a part number specific datasheet for referee time details.	Please refer to a part number specification sheet for specific Aging rate
Terminal Strength	KEMET Internal	Case Size Force 0201 2N 0402 3N 0603 5N 0805 9N ≥1206 18N	No evidence of mechanical damage
Board Flex	AEC-Q200-005	Standard Termination system 2.0 mm Flexible Termination System 3.0 mm Test time: 60± 5 seconds Ramp time: 1 mm/second	No evidence of mechanical damage



X7R Performance and Reliability: SMD Test Methods and Conditions cont.

Test	Reference	Test Condition	Limits			
Solderability	J-STD-002	Condition: 4 hours ± 15 minutes at 155°C dry bake apply all methods Test 245 ±5°C (SnPb and Pb-Free)	Visual Inspection. 95% coverage on termination. No leaching			
Temperature Cycling	JESD22 Method JA-104	1,000 cycles (-55°C to +125°C) 2 - 3 cycles per hour Soak Time 1 or 5 minutes	Measurement at 24 hours ±4 hours after test conclusion. Cap: ±20% shift DF: Initial Limit IR: Initial Limit			
Biased Humidity	MIL-STD-202 Method 103	Load Humidity: 1,000 hours 85°C/85% RH and rated voltage. Low Volt Humidity: 1,000 hours 85C°/85% RH and 1.5 V.	Measurement at 24 hours ±4 hours after test conclusion. Within Post Environmental Limits Cap: ±20% shift IR: 10% of Initial Limit DF Limits Maximum (%) Initial Post 2.5 3.0 3.5 5.0 5.0 7.5 10.0 20.0			
Thermal Shock	MIL-STD-202 Method 107	Number of cycles required 5, (-55°C to 125°C) Dwell time 15 minutes.	Cap:±20% shift DF: Initial Limit IR: Initial Limit DF Limits Maximum (%) Initial Post 2.5 3.0 3.5 5.0 5.0 7.5 10.0 20.0			



X7R Performance and Reliability: SMD Test Methods and Conditions cont.

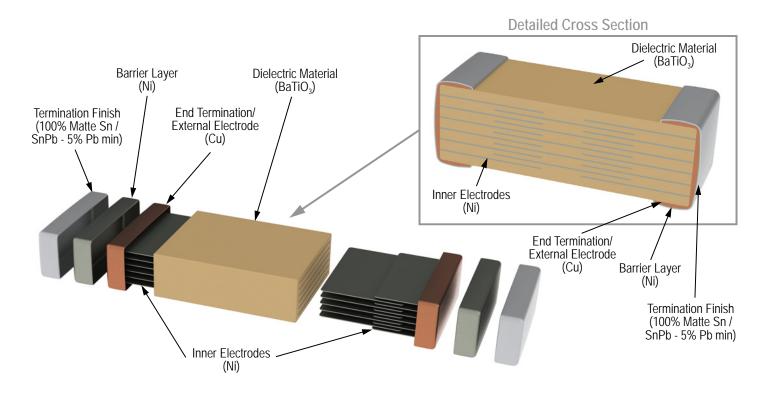
Test	Reference	Test Condition	Limits				
			Within Post Environmental Limits Cap: ±20% shift IR: 10% of Initial Limit				
High	MIL-STD-202	1,000 hours at 125°C with 2 X rated voltage applied	DF Limits Maximum (%)				
Temperature Life	Method 108	excluding the following:	Initial Post				
Lile			2.5 3.0				
			3.5 5.0				
			5.0 7.5				
			10.0 20.0				
Vibration	MIL-STD-202 Method 204	5 g's for 20 minutes, 12 cycles each of 3 orientations. Test from 10 – 2,000 Hz	Cap: ±20% shift DF: Initial Limit IR: Initial Limit				
Resistance to Soldering Heat	MIL-STD-202 Method 210	Condition D, 260°C, 10 seconds	Cap: ±20% shift DF: Initial Limit IR: Initial Limit				

Storage and Handling

Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature—reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. Temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 1.5 years of receipt.



Construction





Capacitor Marking (Optional)

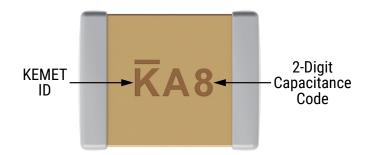
These surface mount multilayer ceramic capacitors are normally supplied unmarked. If required, they can be marked as an extra cost option. Marking is available on most KEMET devices, but must be requested using the correct ordering code identifier(s). If this option is requested, two sides of the ceramic body will be laser marked with a "K" to identify KEMET, followed by two characters (per EIA-198 - see table below) to identify the capacitance value. EIA 0603 case size devices are limited to the "K" character only.

Laser marking option is <u>not</u> available on:

- · COG, ultra stable X8R and Y5V dielectric devices.
- EIA 0402 case size devices.
- EIA 0603 case size devices with flexible termination option.
- KPS commercial and automotive grade stacked devices
- X7R dielectric products in capacitance values outlined below.

EIA Case Size	Metric Size Code	Capacitance
0603	1608	≤ 170 pF
0805	2012	≤ 150 pF
1206	3216	≤ 910 pF
1210	3225	≤ 2,000 pF
1808	4520	≤ 3,900 pF
1812	4532	≤ 6,700 pF
1825	4564	≤ 0.018 µF
2220	5650	≤ 0.027 µF
2225	5664	≤ 0.033 µF

Marking appears in legible contrast. Illustrated below is an example of an MLCC with laser marking of "KA8", which designates a KEMET device with rated capacitance of 100 μ F. Orientation of marking is vendor optional.





Capacitor Marking (Optional) cont.

		onosito	naa (n	T)	Jariana	Alpho/	Mumar	al Idantii	i e re	
		apacita	ince (p	r) ror v				al Identif	iers	
Alpha		0	4		1	Numera				
Character	9	0	1	2	3	4	5	6	7	8
					Capa	citance				
Α	0.10	1.0	10	100	1,000	10,000	100,000	1,000,000	10,000,000	100,000,000
В	0.11	1.1	11	110	1,100	11,000	110,000	1,100,000	11,000,000	110,000,000
С	0.12	1.2	12	120	1,200	12,000	120,000	1,200,000	12,000,000	120,000,000
D	0.13	1.3	13	130	1,300	13,000	130,000	1,300,000	13,000,000	130,000,000
E	0.15	1.5	15	150	1,500	15,000	150,000	1,500,000	15,000,000	150,000,000
F	0.16	1.6	16	160	1,600	16,000	160,000	1,600,000	16,000,000	160,000,000
G	0.18	1.8	18	180	1,800	18,000	180,000	1,800,000	18,000,000	180,000,000
Н	0.20	2.0	20	200	2,000	20,000	200,000	2,000,000	20,000,000	200,000,000
J	0.22	2.2	22	220	2,200	22,000	220,000	2,200,000	22,000,000	220,000,000
K	0.24	2.4	24	240	2,400	24,000	240,000	2,400,000	24,000,000	240,000,000
L	0.27	2.7	27	270	2,700	27,000	270,000	2,700,000	27,000,000	270,000,000
М	0.30	3.0	30	300	3,000	30,000	300,000	3,000,000	30,000,000	300,000,000
N	0.33	3.3	33	330	3,300	33,000	330,000	3,300,000	33,000,000	330,000,000
Р	0.36	3.6	36	360	3,600	36,000	360,000	3,600,000	36,000,000	360,000,000
Q	0.39	3.9	39	390	3,900	39,000	390,000	3,900,000	39,000,000	390,000,000
R	0.43	4.3	43	430	4,300	43,000	430,000	4,300,000	43,000,000	430,000,000
S	0.47	4.7	47	470	4,700	47,000	470,000	4,700,000	47,000,000	470,000,000
T	0.51	5.1	51	510	5,100	51,000	510,000	5,100,000	51,000,000	510,000,000
U	0.56	5.6	56	560	5,600	56,000	560,000	5,600,000	56,000,000	560,000,000
٧	0.62	6.2	62	620	6,200	62,000	620,000	6,200,000	62,000,000	620,000,000
W	0.68	6.8	68	680	6,800	68,000	680,000	6,800,000	68,000,000	680,000,000
Х	0.75	7.5	75	750	7,500	75,000	750,000	7,500,000	75,000,000	750,000,000
Υ	0.82	8.2	82	820	8,200	82,000	820,000	8,200,000	82,000,000	820,000,000
Z	0.91	9.1	91	910	9,100	91,000	910,000	9,100,000	91,000,000	910,000,000
а	0.25	2.5	25	250	2,500	25,000	250,000	2,500,000	25,000,000	250,000,000
b	0.35	3.5	35	350	3,500	35,000	350,000	3,500,000	35,000,000	350,000,000
d	0.40	4.0	40	400	4,000	40,000	400,000	4,000,000	40,000,000	400,000,000
е	0.45	4.5	45	450	4,500	45,000	450,000	4,500,000	45,000,000	450,000,000
f	0.50	5.0	50	500	5,000	50,000	500,000	5,000,000	50,000,000	500,000,000
m	0.60	6.0	60	600	6,000	60,000	600,000	6,000,000	60,000,000	600,000,000
n	0.70	7.0	70	700	7,000	70,000	700,000	7,000,000	70,000,000	700,000,000
t	0.80	8.0	80	800	8,000	80,000	800,000	8,000,000	80,000,000	800,000,000
у	0.90	9.0	90	900	9,000	90,000	900,000	9,000,000	90,000,000	900,000,000



Tape & Reel Packaging Information

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12 and 16 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.

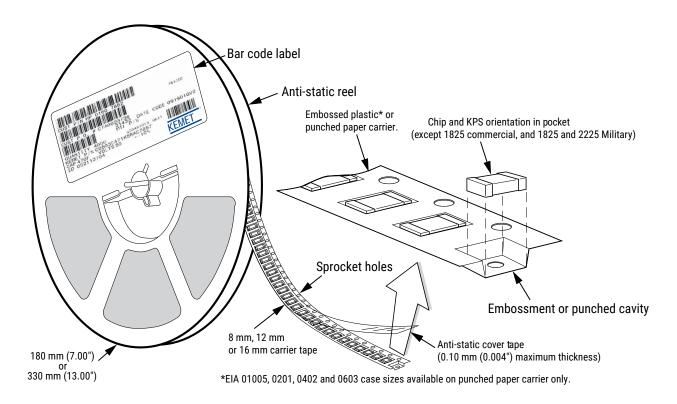


Table 5 - Carrier Tape Configuration, Embossed Plastic & Punched Paper (mm)

		Embosse	ed Plastic	Punched Paper		
EIA Case Size	Tape Size (W)*	7" Reel	13" Reel	7" Reel	13" Reel	
	(**)	Pitch	(P ₁)*	Pitch (P ₁)*		
01005 - 0402	8			2	2	
0603	8			4	4	
0805	8	4	4	4	4	
1206 - 1210	8	4	4	4	4	
1805 – 1808	12	4	4			
≥ 1812	12	8	8			
KPS 1210	12	8	8			
KPS 1812 and 2220	16	12	12			
Array 0612	8	4	4			

^{*}Refer to Figures 1 and 2 for W and P_1 carrier tape reference locations.

^{*}Refer to Tables 6 and 7 for tolerance specifications.



Figure 1 - Embossed (Plastic) Carrier Tape Dimensions

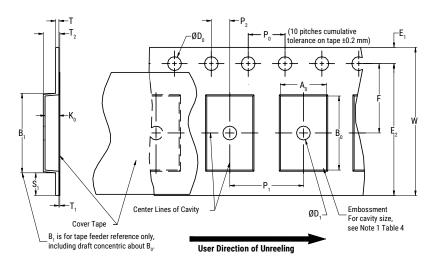


Table 6 - Embossed (Plastic) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)								
Tape Size	D ₀	D ₁ Minimum Note 1	E ₁	P ₀	P ₂	R Reference Note 2	S ₁ Minimum Note 3	T Maximum	T ₁ Maximum
8 mm		1.0 (0.039)				25.0 (0.984)			
12 mm	1.5 +0.10/-0.0 (0.059 +0.004/-0.0)	1.5	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	30	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)
16 mm		(0.059)).059)			(1.181)			
		1	Variable Dime	ensions — Mil	limeters (Inch	nes)			
Tape Size	Pitch	B ₁ Maximum Note 4	E ₂ Minimum	F	P ₁	T ₂ Maximum	W Maximum	A ₀ ,B ₀	& K ₀
8 mm	Single (4 mm)	4.35 (0.171)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	2.5 (0.098)	8.3 (0.327)		
12 mm	Single (4 mm) and double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5 ±0.05 (0.217 ±0.002)	8.0 ±0.10 (0.315 ±0.004)	4.6 (0.181)	12.3 (0.484)	Not	te 5
16 mm	Triple (12 mm)	12.1 (0.476)	14.25 (0.561)	7.5 ±0.05 (0.138 ±0.002)	12.0 ±0.10 (0.157 ±0.004)	4.6 (0.181)	16.3 (0.642)		

- 1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of the embossment location and the hole location shall be applied independently of each other.
- 2. The tape with or without components shall pass around R without damage (see Figure 6.)
- 3. If S₁ < 1.0 mm, there may not be enough area for a cover tape to be properly applied (see EIA Standard 481, paragraph 4.3, section b.)
- 4. B, dimension is a reference dimension for tape feeder clearance only.
- 5. The cavity defined by A_{n} , B_{n} and K_{n} shall surround the component with sufficient clearance that:
 - (a) the component does not protrude above the top surface of the carrier tape.
 - (b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
 - (c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3.)
 - (d) lateral movement of the component is restricted to 0.5 mm maximum for 8 and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4.)
 - (e) for KPS product, A_0 and B_0 are measured on a plane 0.3 mm above the bottom of the pocket.
 - (f) see addendum in EIA Standard 481 for standards relating to more precise taping requirements.



Figure 2 - Punched (Paper) Carrier Tape Dimensions

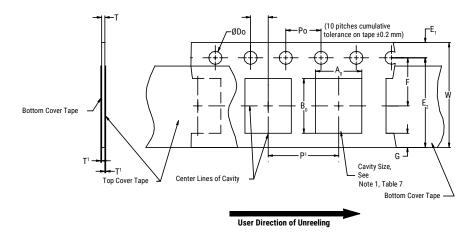


Table 7 - Punched (Paper) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)							
Tape Size	D _o	E ₁	P ₀	P ₂	T ₁ Maximum	G Minimum	R Reference Note 2	
8 mm	1.5 +0.10 -0.0 (0.059 +0.004 -0.0)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	0.10 (0.004) maximum	0.75 (0.030)	25 (0.984)	
		Variable D	imensions — M	illimeters (Inche	es)			
Tape Size	Pitch	E2 Minimum	F	P ₁	T Maximum	W Maximum	$A_0 B_0$	
8 mm	Single (4 mm)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	1.1 (0.043)	8.3 (0.327)	Note 1	

- 1. The cavity defined by $A_{or} B_{o}$ and T shall surround the component with sufficient clearance that:
 - a) the component does not protrude beyond either surface of the carrier tape.
 - b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
 - c) rotation of the component is limited to 20° maximum (see Figure 3.)
 - d) lateral movement of the component is restricted to 0.5 mm maximum (see Figure 4.)
 - e) see addendum in EIA Standard 481 for standards relating to more precise taping requirements.
- 2. The tape with or without components shall pass around R without damage (see Figure 6.)



Packaging Information Performance Notes

1. Cover Tape Break Force: 1.0 kg minimum.

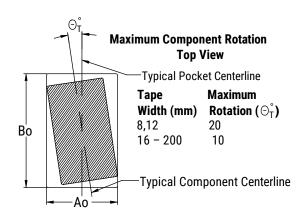
2. Cover Tape Peel Strength: The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength
8 mm	0.1 to 1.0 newton (10 to 100 gf)
12 and 16 mm	0.1 to 1.3 newton (10 to 130 gf)

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be 165° to 180° from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of 300 ±10 mm/minute.

3. Labeling: Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards 556 and 624*.

Figure 3 - Maximum Component Rotation



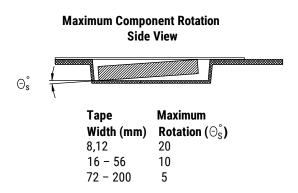


Figure 4 - Maximum Lateral Movement

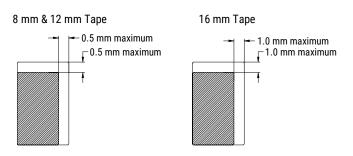


Figure 5 - Bending Radius

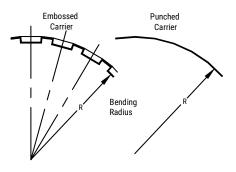
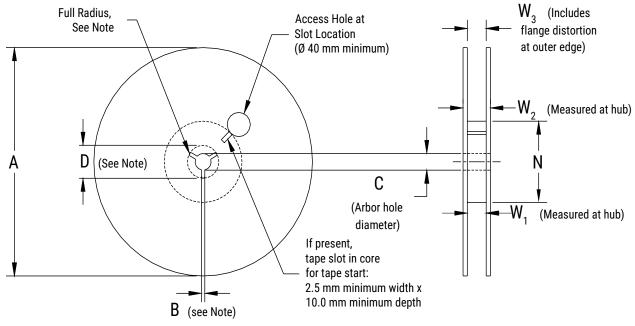




Figure 6 - Reel Dimensions



Note: Drive spokes optional; if used, dimensions B and D shall apply.

Table 8 - Reel Dimensions

Metric will govern

Constant Dimensions — Millimeters (Inches)				
Tape Size	A	B Minimum	С	D Minimum
8 mm	178 ±0.20 (7.008 ±0.008) or 330 ±0.20 (13.000 ±0.008)	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)
12 mm				
16 mm				
Variable Dimensions — Millimeters (Inches)				
Tape Size	N Minimum	W ₁	W ₂ Maximum	W ₃
8 mm	50 (1.969)	8.4 +1.5/-0.0 (0.331 +0.059/-0.0)	14.4 (0.567)	Shall accommodate tape width without interference
12 mm		12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	
16 mm		16.4 +2.0/-0.0 (0.646 +0.078/-0.0)	22.4 (0.882)	



Figure 7 - Tape Leader & Trailer Dimensions

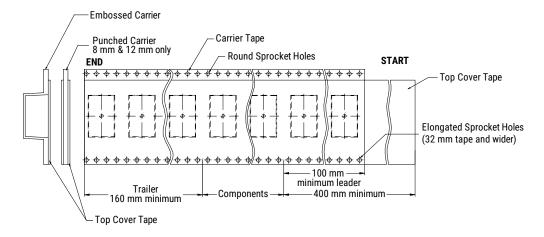
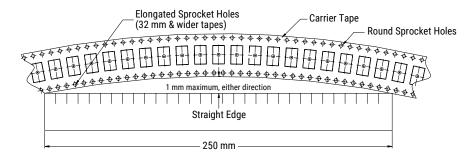


Figure 8 - Maximum Camber





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